## Application/Control No. Applicant(s)/Patent Under Reexamination 09/989,858 NAKAMURA ET AL Notice of References Cited Art Unit Examiner Page 1 of 1 2665 Phuongchau Ba Nguyen **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 05-2002 370/513 US-6,385,213 B1 Nakamura et al. Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-Κ US-US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s T

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